

# Using EMC testing equipment as a new side channel acquisition technique

Hardwear.io NL 2022

# Who are those guys ?

## Benjamin VERNOUX

Embedded Hardware / Firmware / Host tools

SDR: AirSpy R0-R2/Mini

HydraBus v1 / HydraNFC v1&v2...

HydraUSB3 v1

## Nicolas OBERLI

Embedded security by day

- Security evaluations
- Side channel, fault injection, ...

Hardware hacking by night

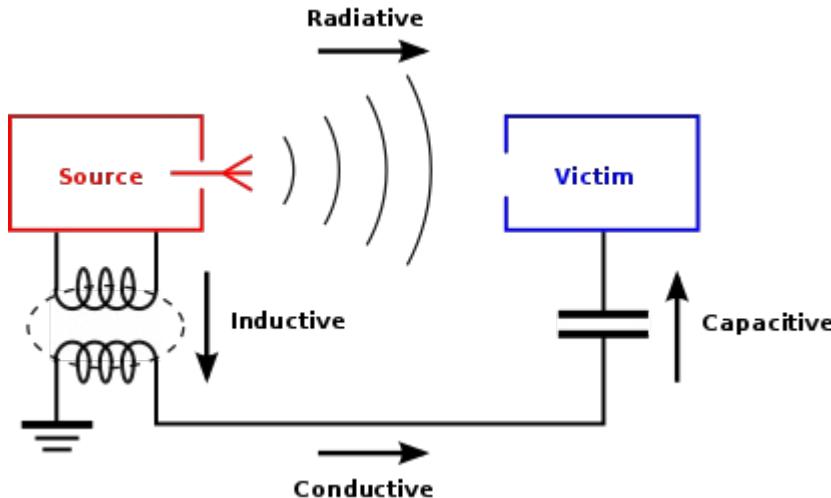
- Same, but cheaper



# EMC ?

- ElectroMagnetic Compatibility
  - Wikipedia : “ability of electrical equipment and systems to function acceptably in their electromagnetic environment”
  - Does the device under test (DUT) behave normally in case of electromagnetic interference (EMI) ?
  - Does the DUT generate EMI ?
- Mandatory for commercial products

# Types of EMI coupling



- **Radiative Coupling** – When an unwanted signal is transferred from source equipment to victim equipment by radiation through space.
- **Inductive Coupling** – The source and the victim are coupled by a magnetic field.
- **Conducted Coupling** – When there is a conduction route along which the signals can travel. This may be along power cables or other inter-connection wires. The conduction may be in one of two modes:
- **Capacitive Coupling** – The level of disturbance depends on the voltage variations ( $dv/dt$ ) and the value of the coupling capacitance between the disturber and the victim.

# Types of EMI coupling “Radiative”

Radiated emissions testing involves measuring the electromagnetic field strength of the emissions that are unintentionally generated by the DUT

## Near Field Probes



Radiated Emissions measurements from <1MHz up to 6GHz with preamplifier (20dB or 40dB)

Can be used with an Oscilloscope or a Spectrum Analyzer

Tekbox TBPS01-TBWA2 EMC near field probe set

# Types of EMI coupling “Radiative”

# Ultra Wide Band Antenna / Log-Periodic Antenna



# 375MHz - 6GHz RFSPACE TSA400

## (Gain >4dBi)



## **380MHz - 6GHz DEEPACE KC-R100B (Gain >5dBi)**

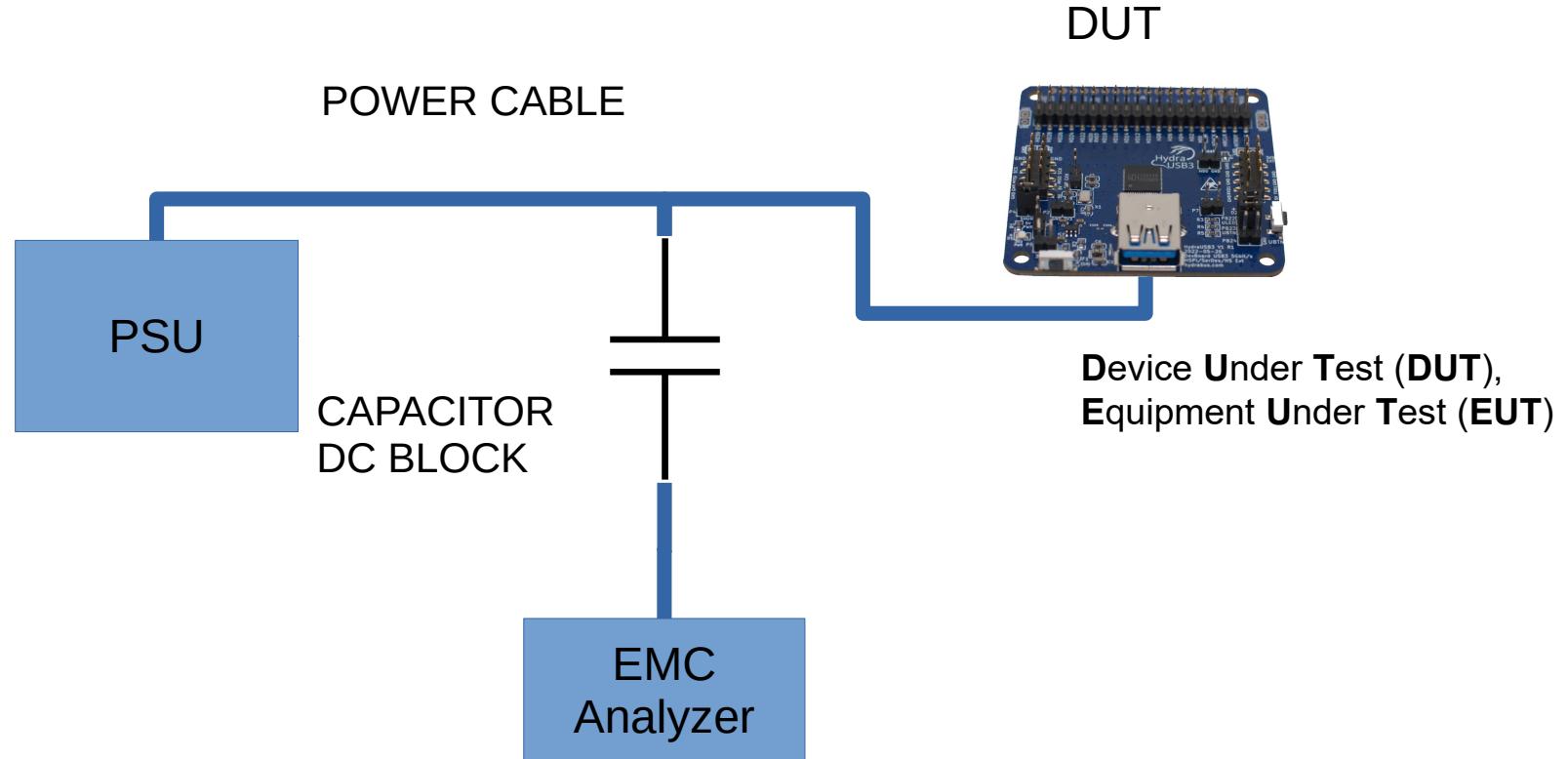
# Our assumption (and why we are here today)

- Radiated and induced EM emissions can already be used to perform SCA
- Can conducted EM signals do the same ?
- Couldn't find any reference in academic papers
  - Usually a bad sign
- Only one way to find out: testing !

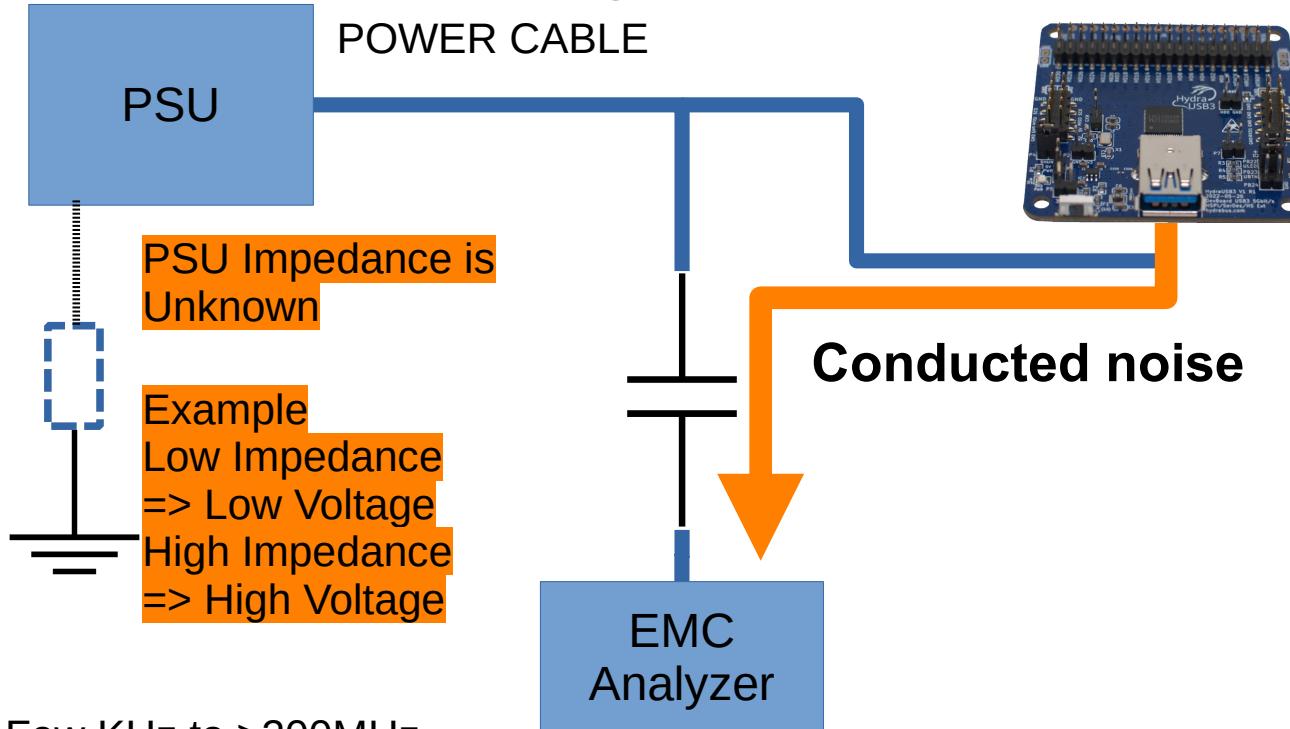


EMI coupling “Conductive”

# Types of EMI coupling “Conductive”

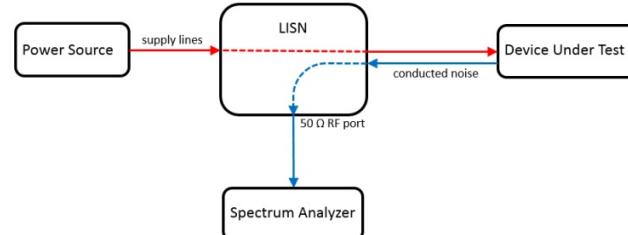


# Types of EMI coupling “Conductive” DUT



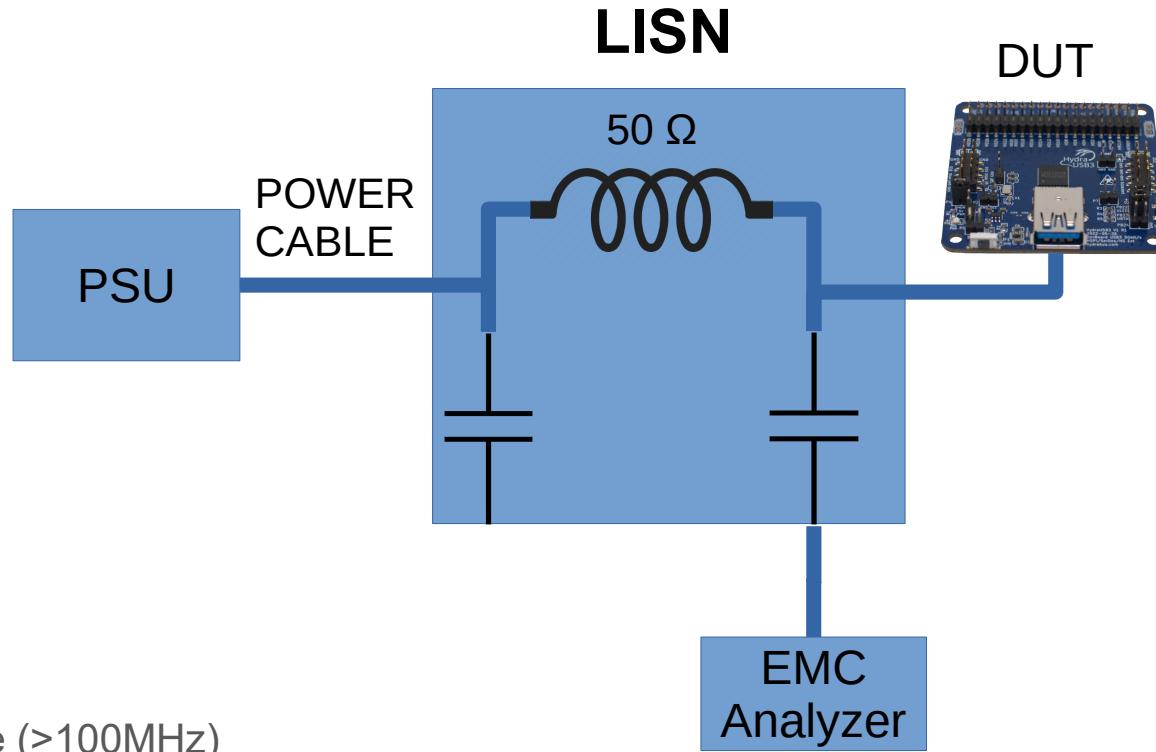
# LISN

- Line Impedance Stabilization Network
  - Low pass filter (cutoff freq 250Hz in our design) typically placed between a power source and the supply terminals of a device under test (DUT).
- Used in EMC testing
  - Provides a well-defined RF-impedance to the DUT ( $50 \Omega$ )
    - To have lowest loss / maximum power transfer in RF (captured with Scope/SA)
  - Filters power supply noise



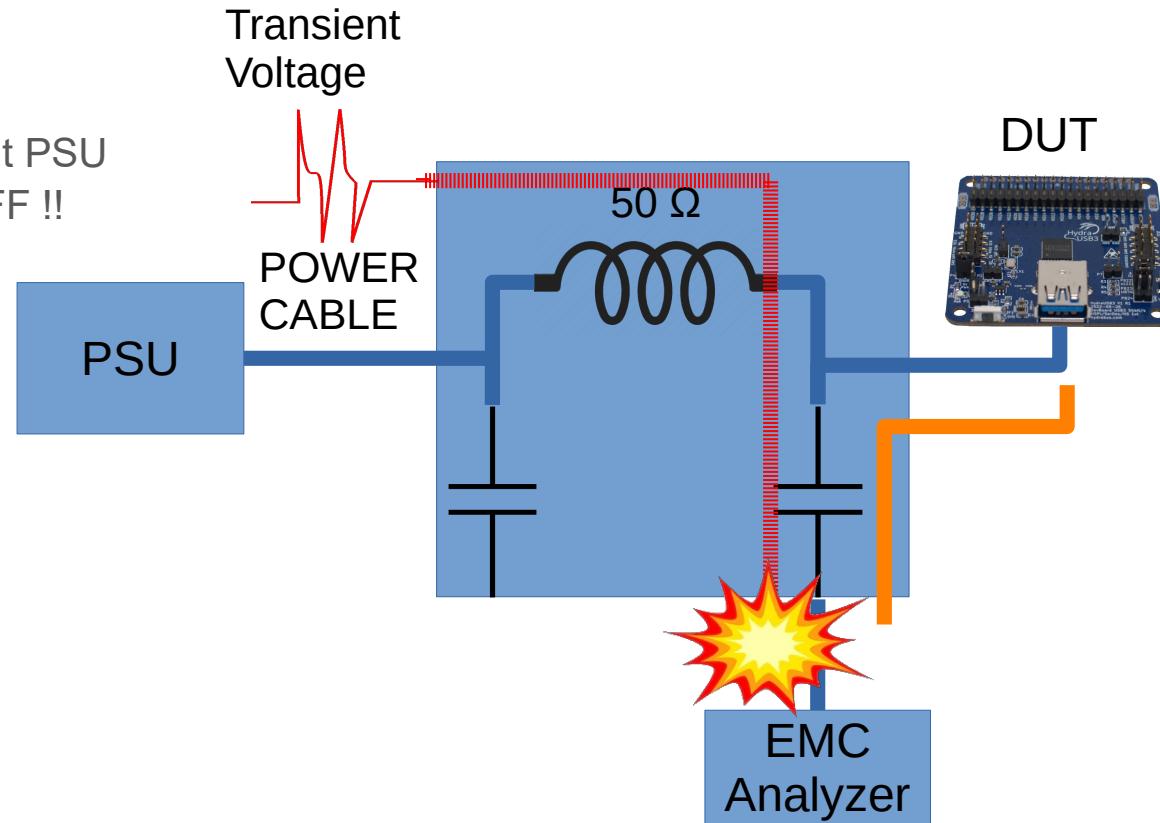
- Provides measurement port for RF noise

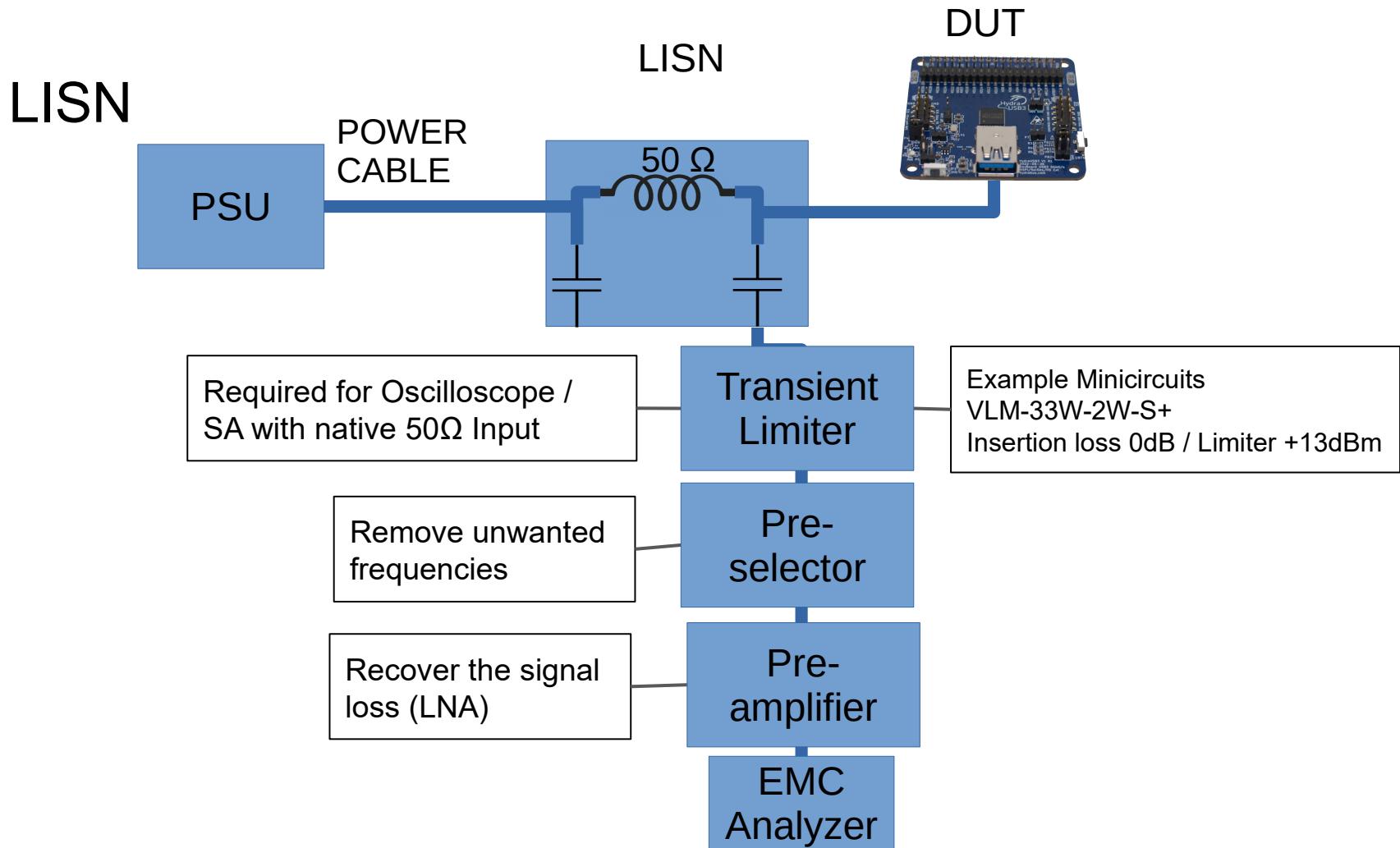
# LISN



# LISN

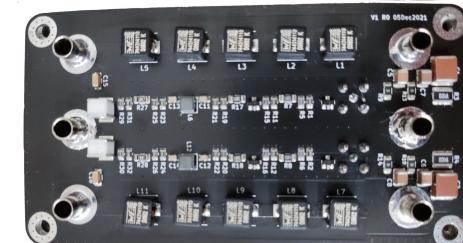
WARNING about PSU  
SWITCH ON/OFF !!





# DIY LISN

- Commercial LISNs are quite costly (400+€)
  - Well known DC 5 $\mu$ H LISN are TekBox DC LISN 5uH (cost 249USD/unit) => Dual DC LISN requires 2x so > 500 USD
- Let's build our own !
  - Fully Open Hardware Dual DC LISN available on Github

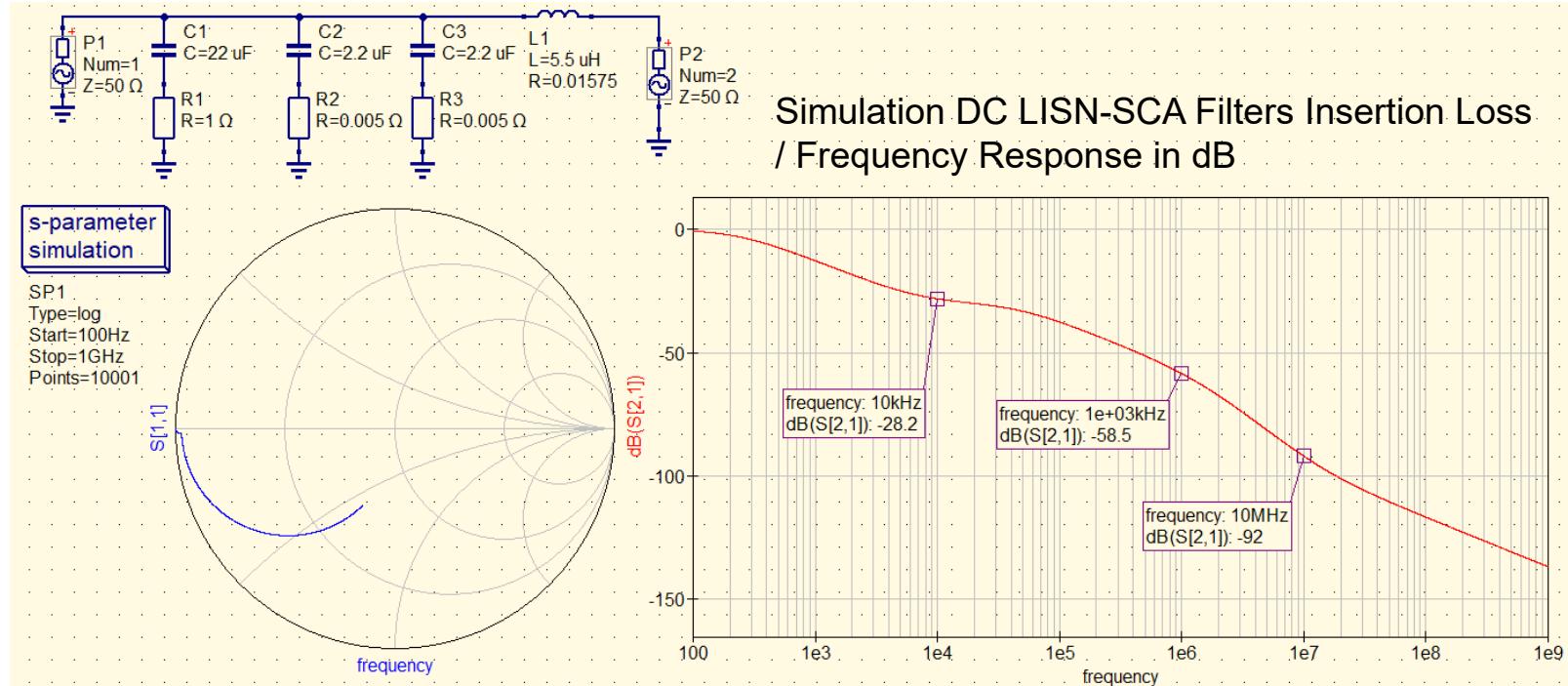


# LISN for SCA

- LISNs usually have attenuators to avoid damaging measurement tools
  - Might dampen the signal
  - Standard LISN output is  $50\Omega$  matched
    - Cannot use oscilloscope  $50\Omega$  termination
      - Requires a Transient Limiter to avoid potential permanent damage to the Oscilloscope Input
    - Must use an  $50\Omega$  Impedance Adapter to connect to oscilloscope  $1M\Omega$  Input
- Solution: remove the attenuator and add input protection
  - We'll be using an oscilloscope anyways

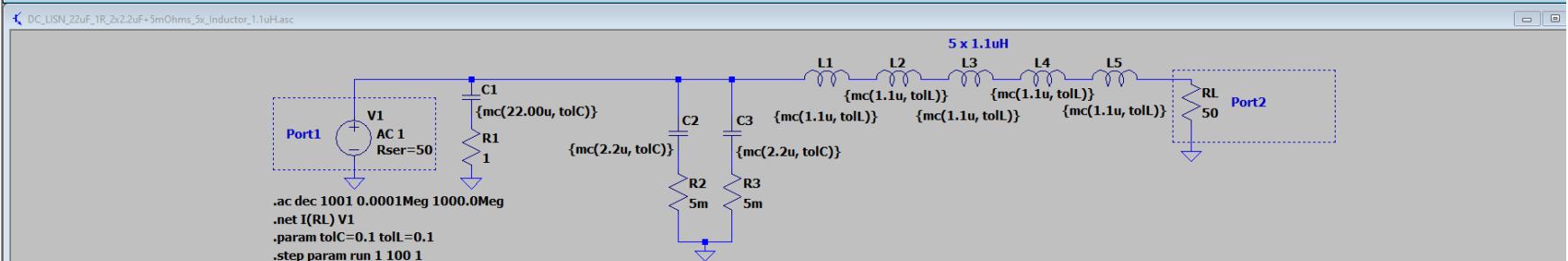
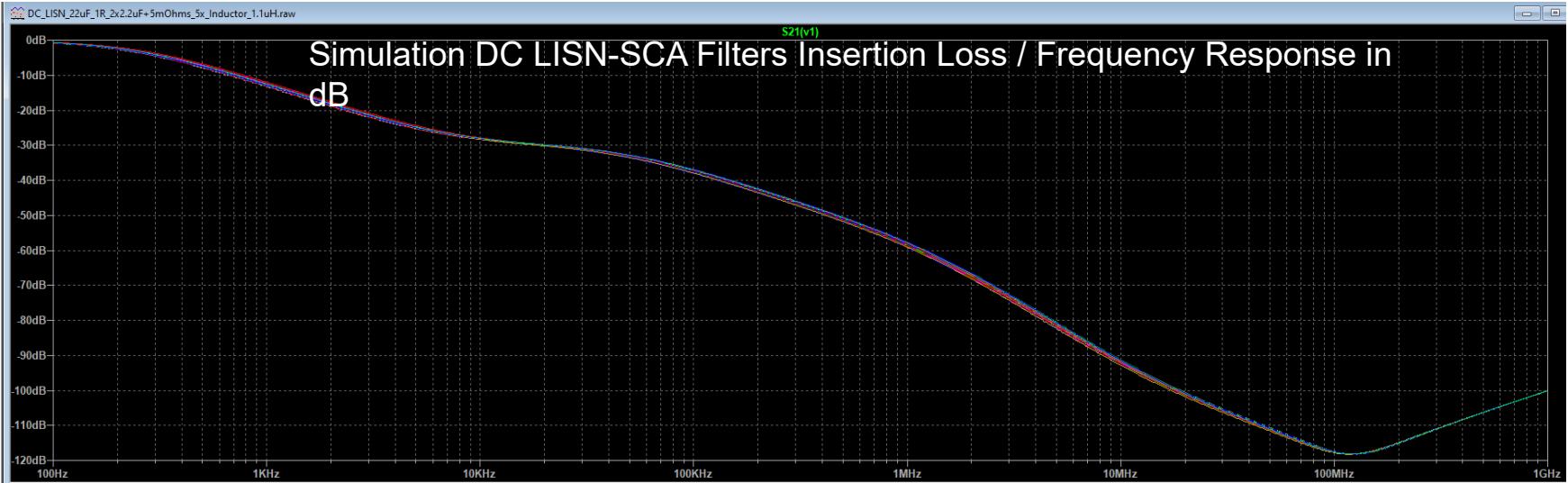
# Conception of a DC-LISN SCA

## Simulation LP Filters+5μH Inductors (QucsStudio 4.3.1)



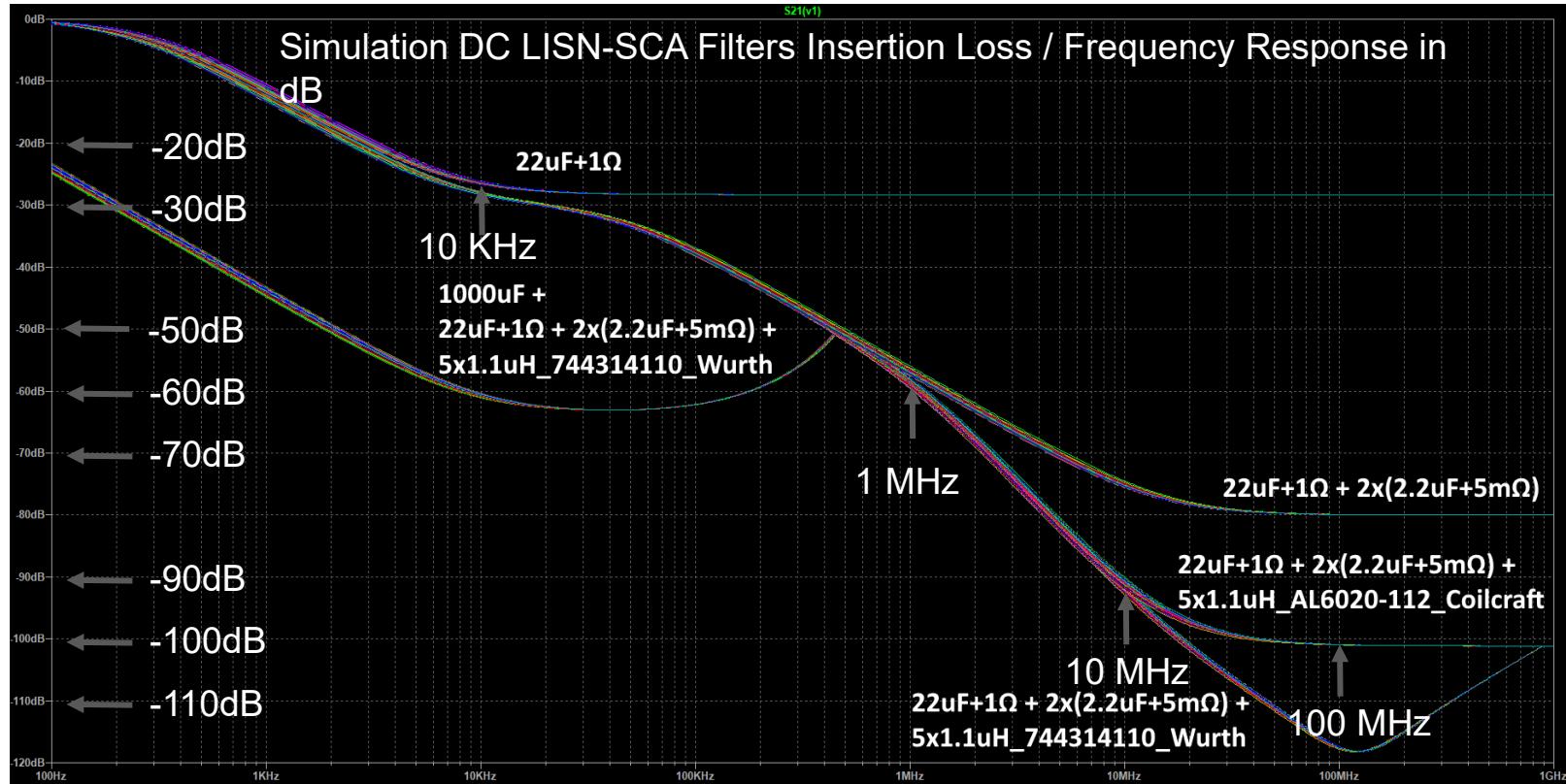
# Conception of a DC-LISN SCA

## Simulation LP Filters+5μH Inductors (LTSpice)

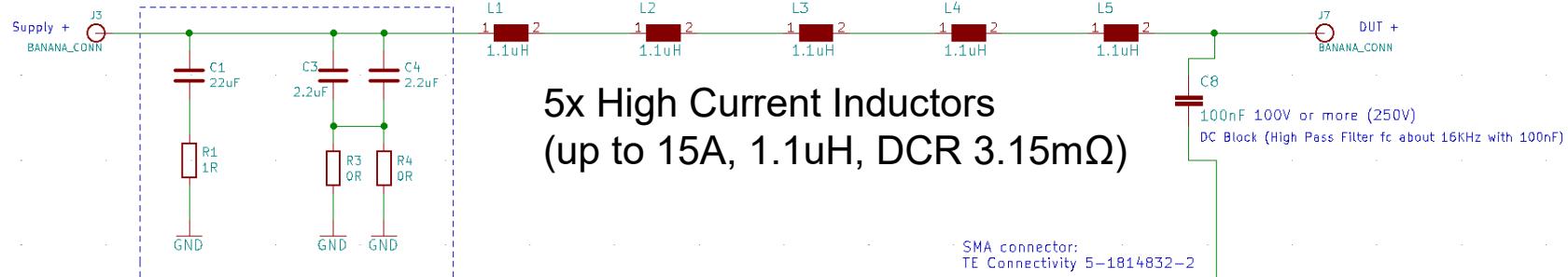


# Conception of a DC-LISN SCA

## Simulation LP Filters+5μH Inductors (LTSpice)



# Conception of a DC-LISN SCA Schematic (KiCad 6)



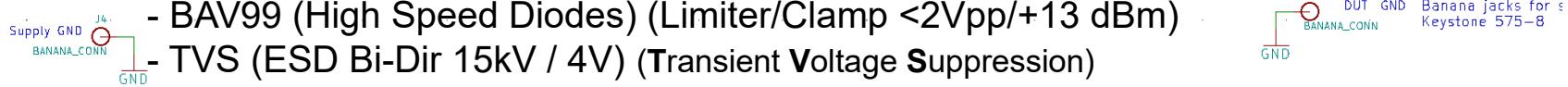
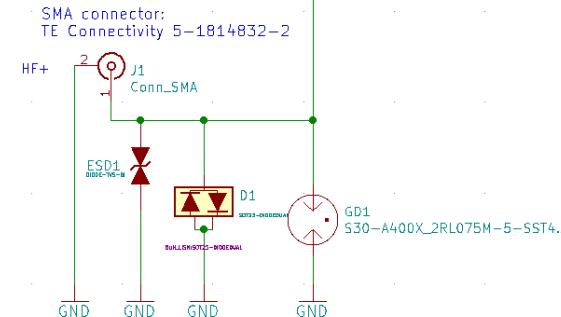
Low Pass Filter (cutoff freq 240Hz)  
22uF+1Ω and 2x(2.2uF+5mΩ)

Protections on HF+/HF-(also called RF+/RF-)

- GDT (75V 5kA Lightning Disturbance)
- BAV99 (High Speed Diodes) (Limiter/Clamp <2Vpp/+13 dBm)
- TVS (ESD Bi-Dir 15kV / 4V) (Transient Voltage Suppression)

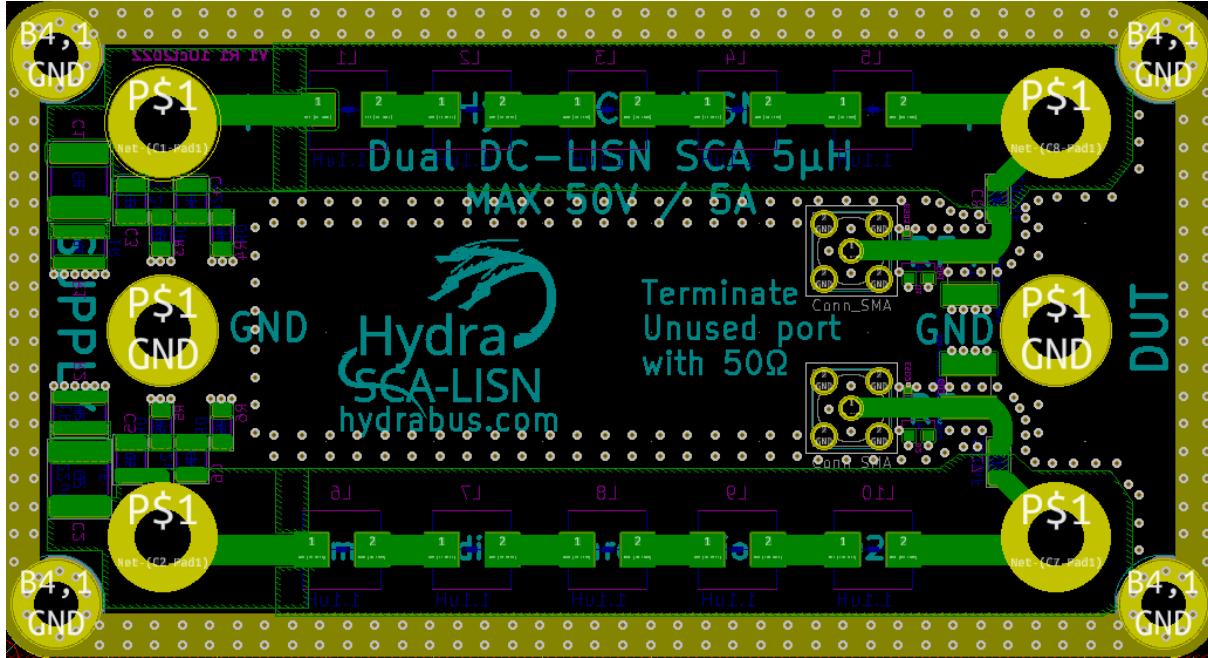
ESD suppressor and Transient Limiter to < 2Vpp(+13 dBm)

- Tested with SigGen & PSU 40V DC Supply (Switch ON/OFF)...



J6 DUT GND Banana jacks for s  
BANANA\_CONN Keystone 575-8

# Conception of a DC-LISN SCA PCB (KiCad 6)



PCB 2 Layers 1.6mm(Core 1.5mm)  
FR4-STD (Er 4.6)

Saturn PCB Toolkit V8.21

**Conductor Impedance => Impedance  
50 Ohms**

**Computation for Inductances traces ("L1-L5" / "L6-L10") Microstrip**

Conductor Width: 2.8mm

Conductor Height: 1.5mm

Z0 computed: 50.1 Ohms

L0 computed: 3.0880 nH/cm

C0 computed: 1.2321 pF/cm

**Computation for RF traces ("RF+"<=>"DUT+" / "RF-"<=>"DUT-")**

**Coplanar Wave**

Conductor Width: 1.88mm

Conductor Height: 1.5mm

Conductor Gap: 0.47mm

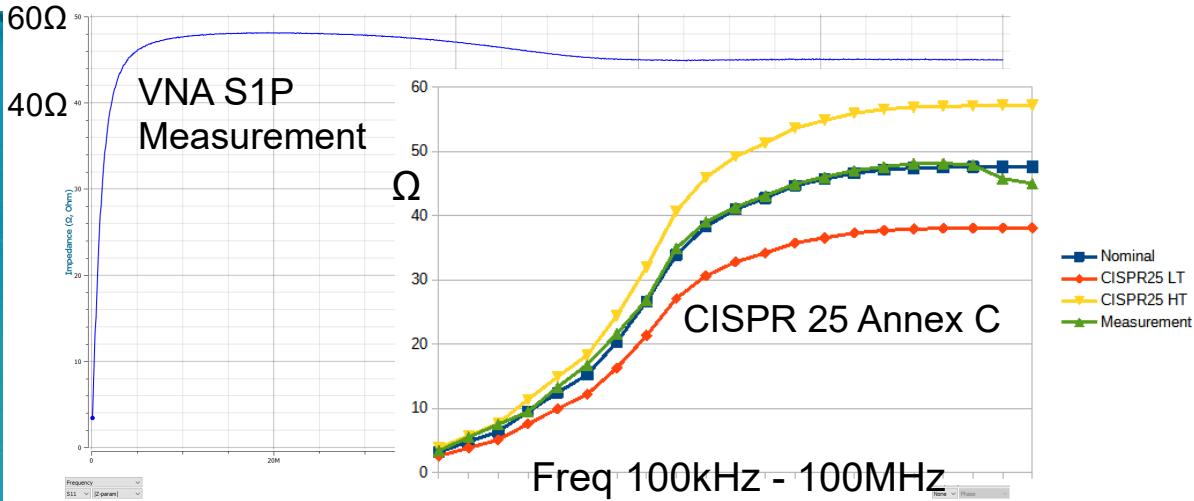
Z0 computed: 50.12 Ohms

# Conception of a DC-LISN SCA Final Board

- HydraSCA-LISN have Input protections/Limiter to protect Oscilloscope (or Spectrum Analyzer) Input even with native 50Ω
  - About +10 dBm Limiter



# DC-LISN SCA Measurements with VNA (Impedance)



## Measurement Impedance(Z) (100kHz - 100MHz)

3.4Ω at 100 kHz => 11Ω at 350 kHz

$>21\Omega$  at  $>700$  kHz     $\Rightarrow 32\Omega$  at 1.2 MHz

>40Ω at 2MHz

=> >44Ω at 5MHz

>47Ω from 7 MHz to 40 MHz

$45\Omega$  from 60 MHz to > 100 MHz

# DC-LISN SCA Measurements with VNA (Filters/Isolation)

Measurement of Isolation (Filter) between SUPPLY +/GND & DUT +/GND



SUPPLY + / GND => VNA Port1  
DUT + / GND => VNA Port2



Measurement Filters/Isolation

- 1 => -33 dB at 30 KHz
- 2 => -68 dB at 1.5 MHz
- 3 => -58 dB at 4 MHz
- 4 => -61 dB at 60 MHz
- 5 => -49 dB at 110 MHz

# DC-LISN SCA Measurements with VNA (Insertion Loss)

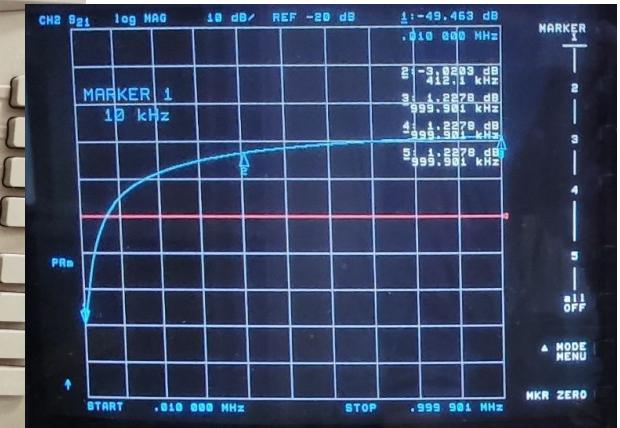
Measurement of InsertionLoss/Bandwidth & cutoff Frequency between DUT +/GND & HF+



HF+ => VNA Port1  
DUT + / GND => VNA Port2

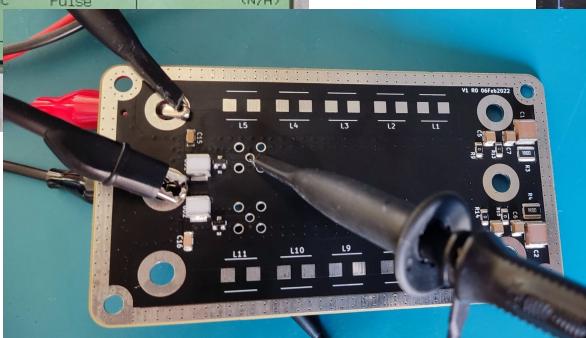
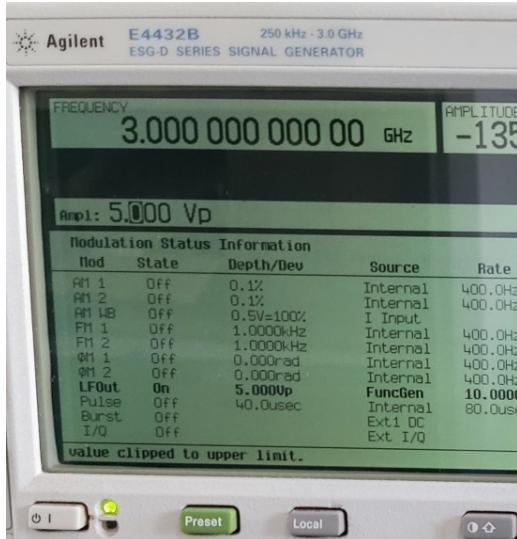


Bandwidth measurement  
> 430MHz (-3dB)



DC Block + Protections (HF+)  
Low Pass Filter cutoff freq > 400 KHz  
(Simulation 16KHz 100nF Capacitor)

# DC-LISN SCA Measurements Limiter/Clamp

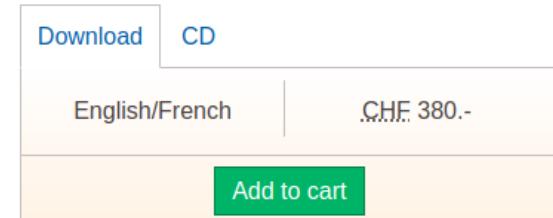


**LISN SCA**  
Signal Input 10Vpp 10kHz Triangle  
RF Protection clamp signal to <2Vpp  
(<1.8Vpp max about +10dBm) to  
protect sensitive Oscilloscope Input  
(50Ω native) or Spectrum Analyzer  
Input

# Measurement setup

# Measurement setup

- Standardized by IEC : CISPR 25
  - Not free :(
  - Old version can be found using google dorks
- Gives lots of information about measurement setup
- Tekbox documentation provides the same information we need



YOU WOULDN'T  
DOWNLOAD A STANDARD

# Measurement setup - cont.

- Stay as close as a standard EMC measurement setup

- Earthing
- Ground plane
- Cable lengths
- Support

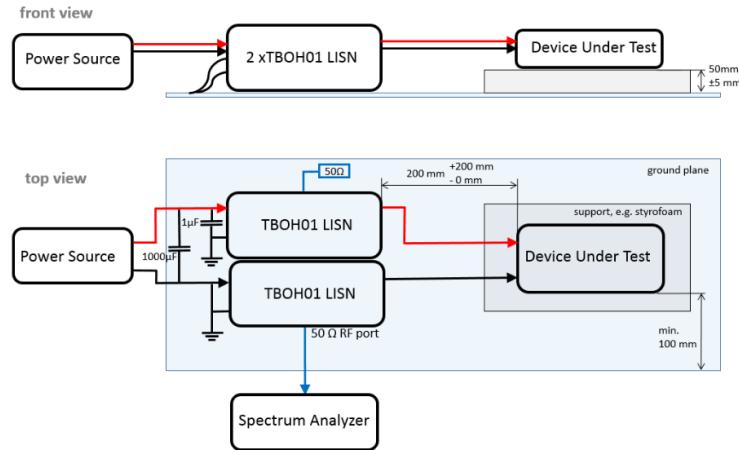
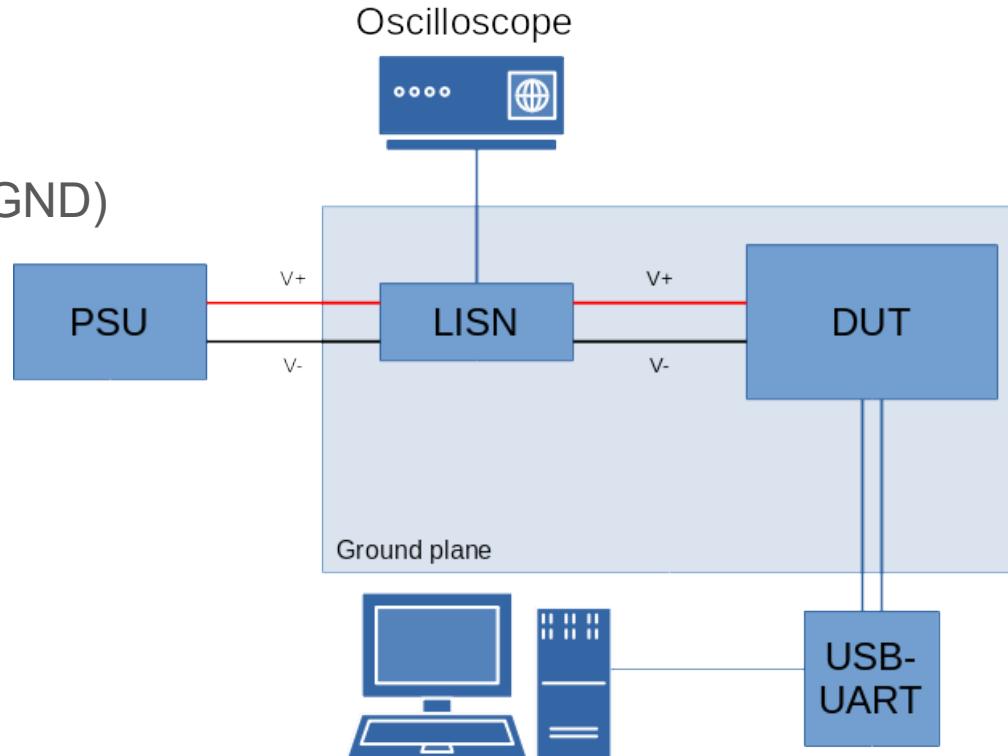


Figure 10: conducted emission measurement, voltage method, DUT with power return line remotely grounded

# Test setup

- STM32 “bluepill”
  - Decoupling capacitors removed
- LISN on both power rails (+3.3V/GND)
- Rigol MSO5000 oscilloscope
  - 350MHz / 4GSPS
- Ground plane connected to earth
- LISN <-> DUT cables max. 20cm



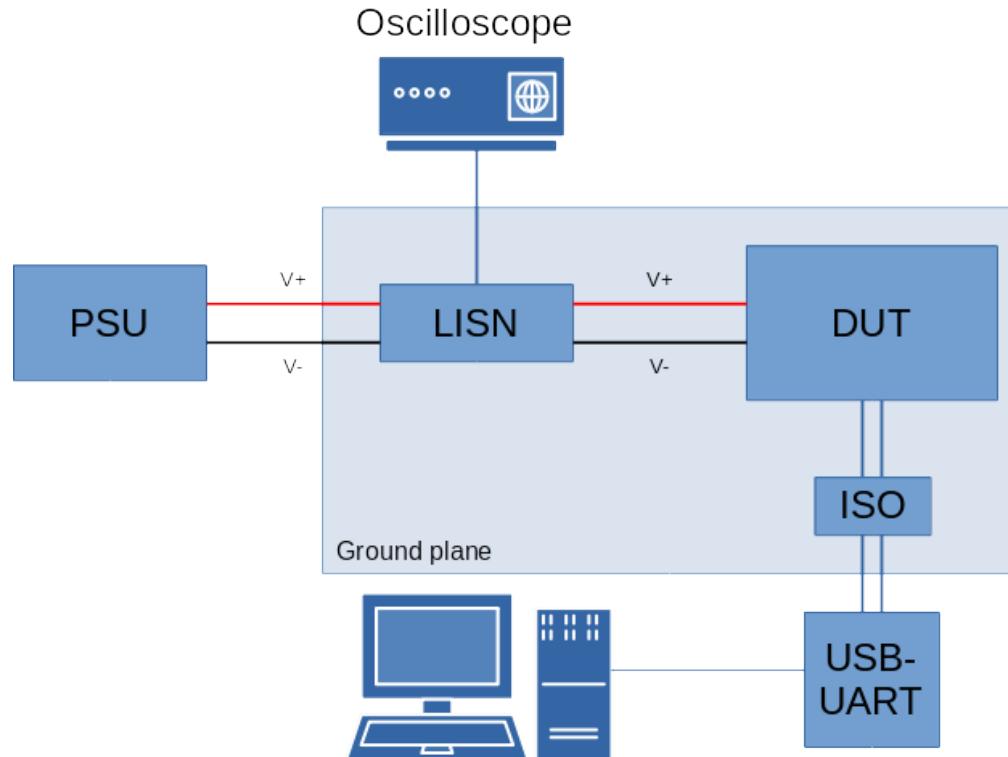
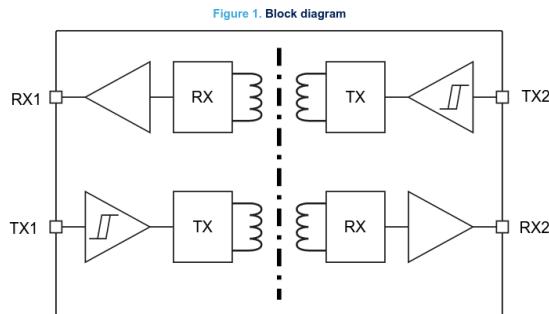


# Objection !

- Need UART to communicate with target
- Means we will bring in conducted EMI from PC to DUT
- More noise means lesser correlation on traces

# Communication isolation

- Easy solution : optocouplers
  - Salvaged from old PSU
  - Works @9600bps
- Better solution : digital isolator
  - Faster communication is possible



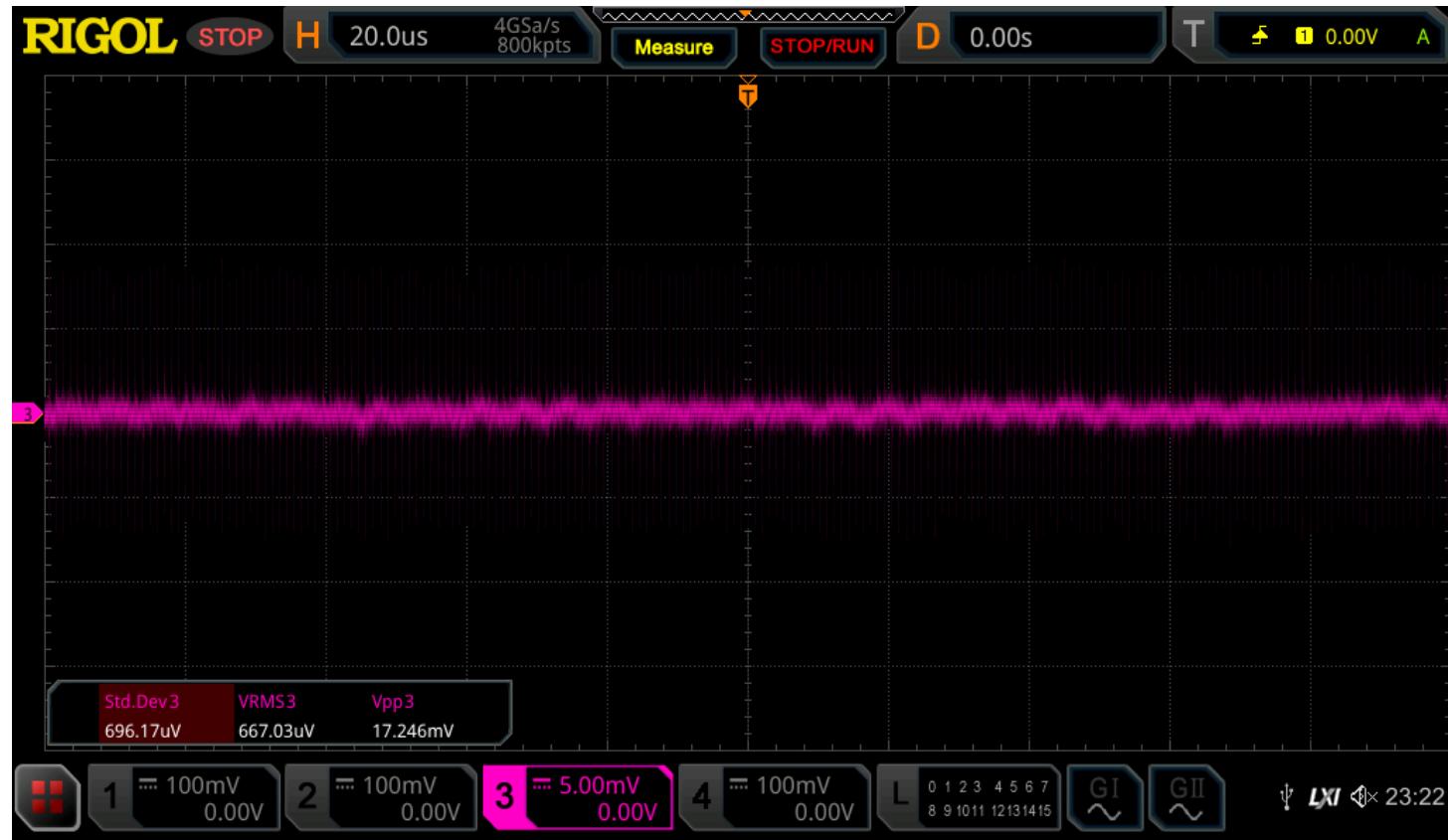
# Direct connection



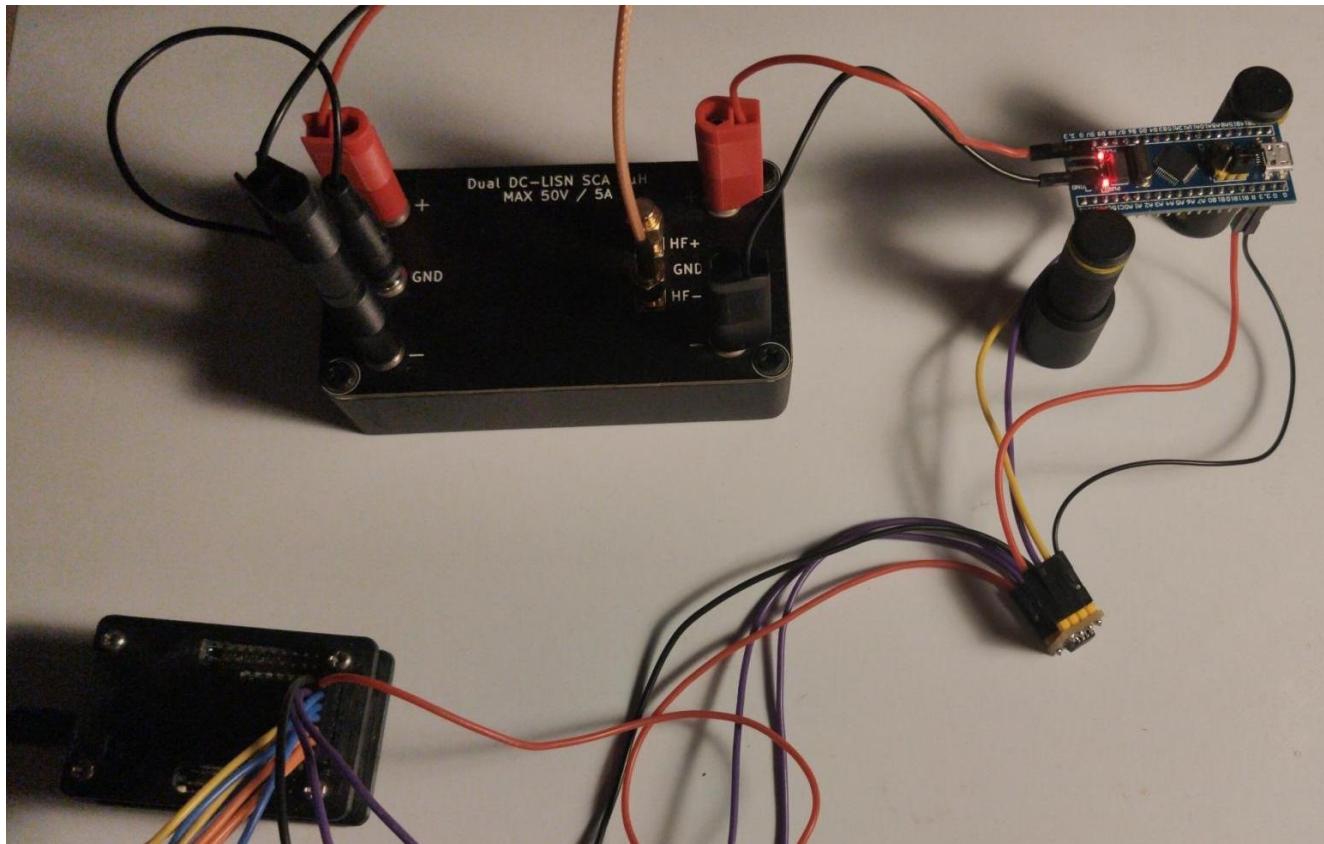
# Isolator



# Isolator + ground plane



# Final setup

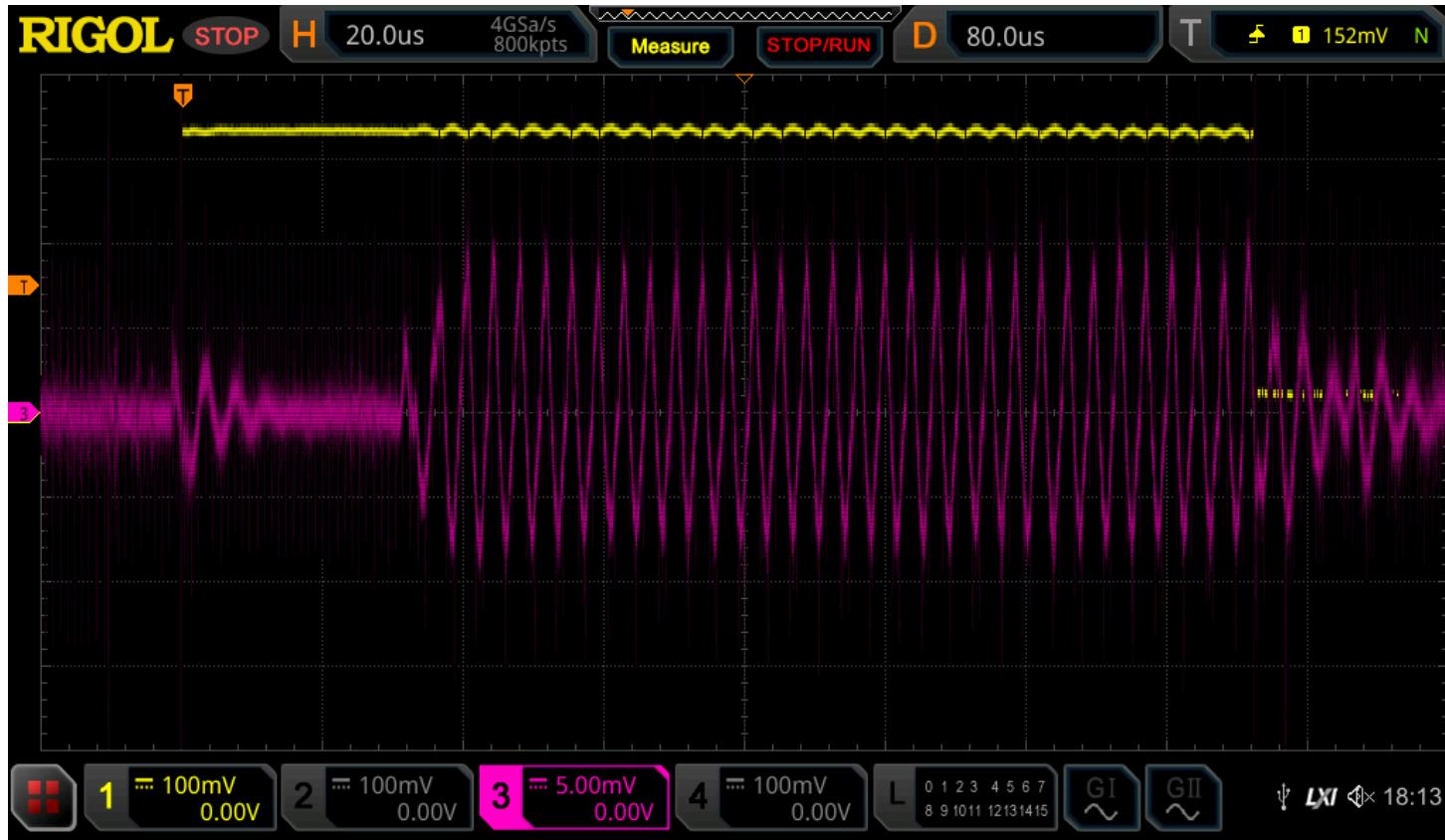


# Software side

- Software SM4
  - GPIO as trigger
  - 16 bytes of input
  - 16 bytes of output
- If everything goes well, we should see the 32 rounds



# We have a signal !

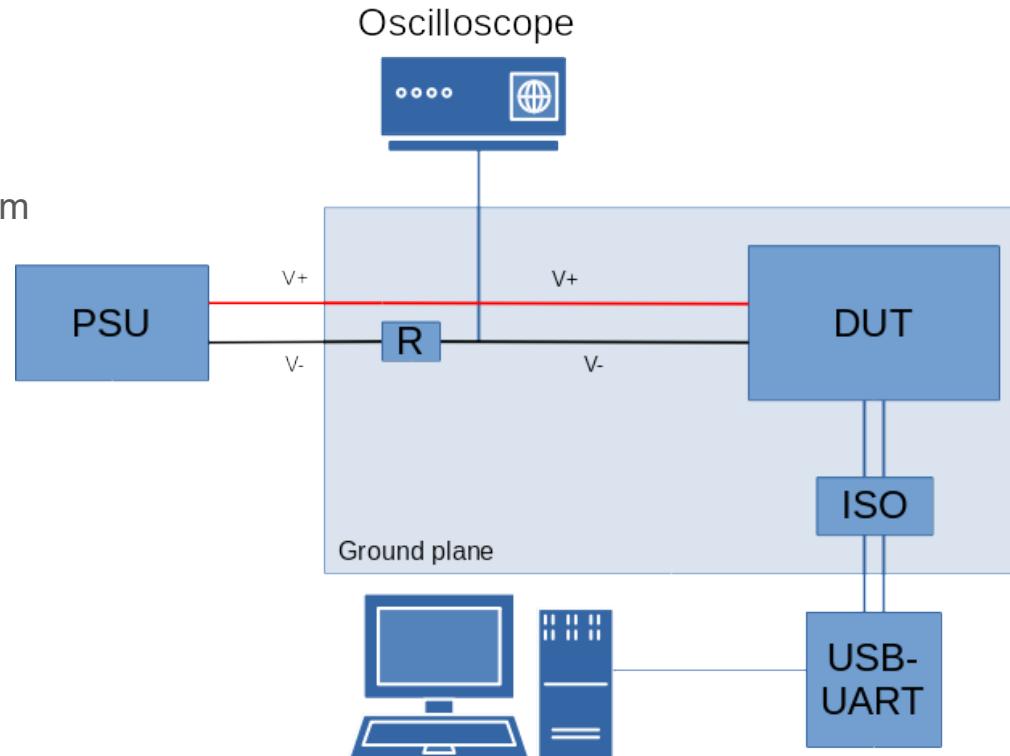


# So far so good

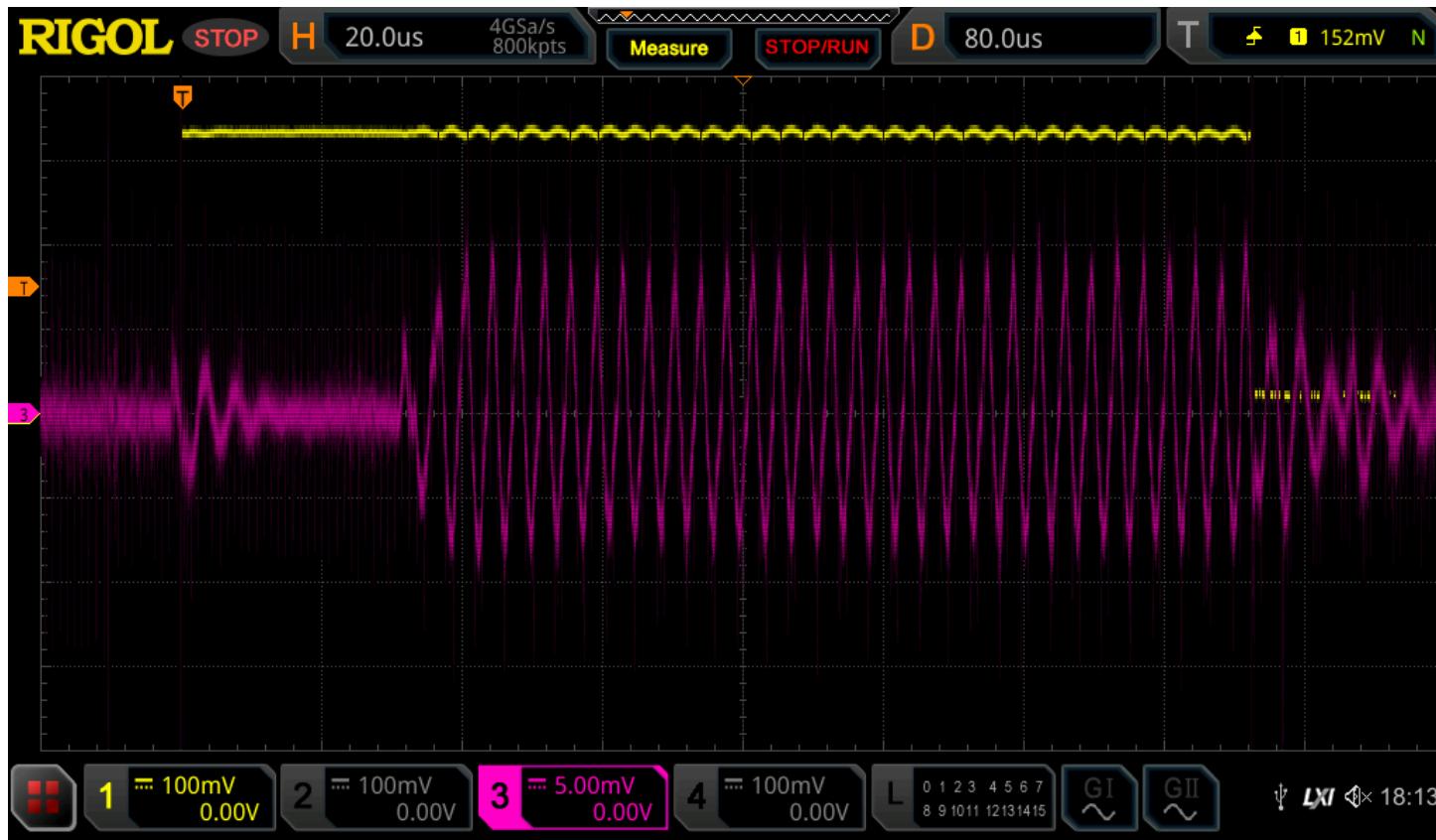
- Traces seem to be useable
- Can we compare this technique with others ?
- Shunt resistor is a good candidate
  - Similar placement in the circuit
  - Affordable / easy setup

# Shunt resistor setup

- SM4 on STM32
- 1 Ohm resistor placed on GND
  - FYI: LISN line resistance is 0.16 Ohm
- Everything else unchanged



# Setup 1 - LISN

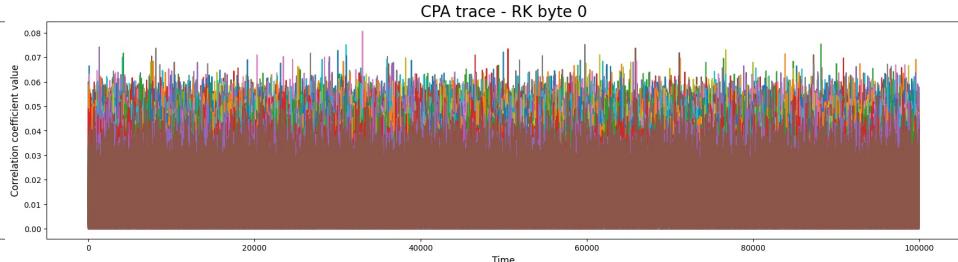
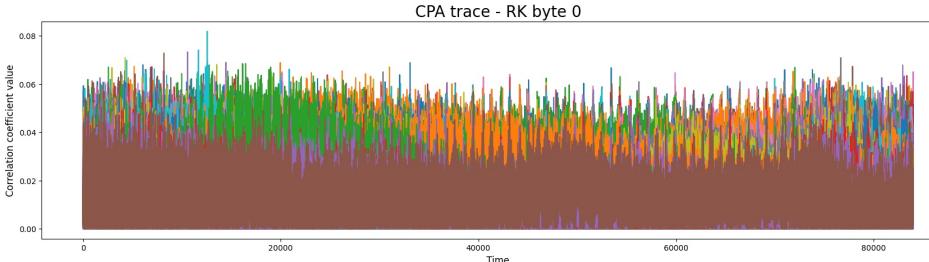


# Setup 1 - Shunt



# CPA

- 5000 traces acquired
  - Random plaintext
  - No resync
- Results on first round :
  - LISN : 3/4 bytes recovered. Last byte is the second candidate
  - Shunt : No correlation

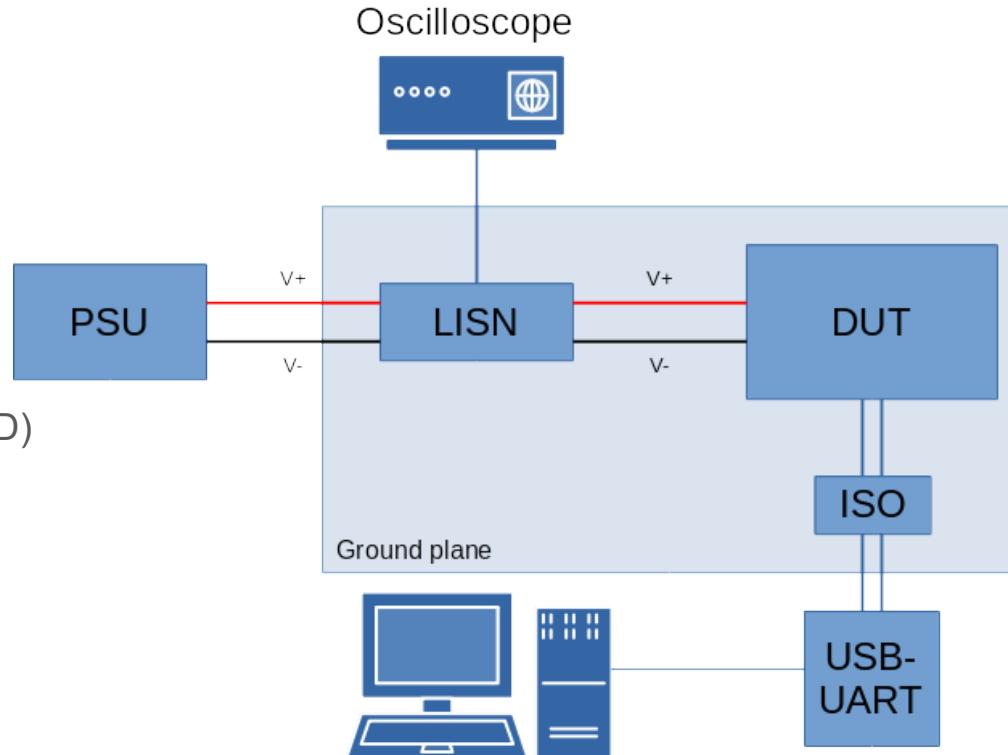


# Exploiting signals

- LISN provides a better dynamic range compared to shunt
  - Allows key recovery with less traces
- Signal is also less noisy
  - Can also be due to my cheap power supply
- Quite old chip, CPU leaks a lot
- Would it be the same with a more recent chip ?
- Does the technique work with decoupling capacitors ?

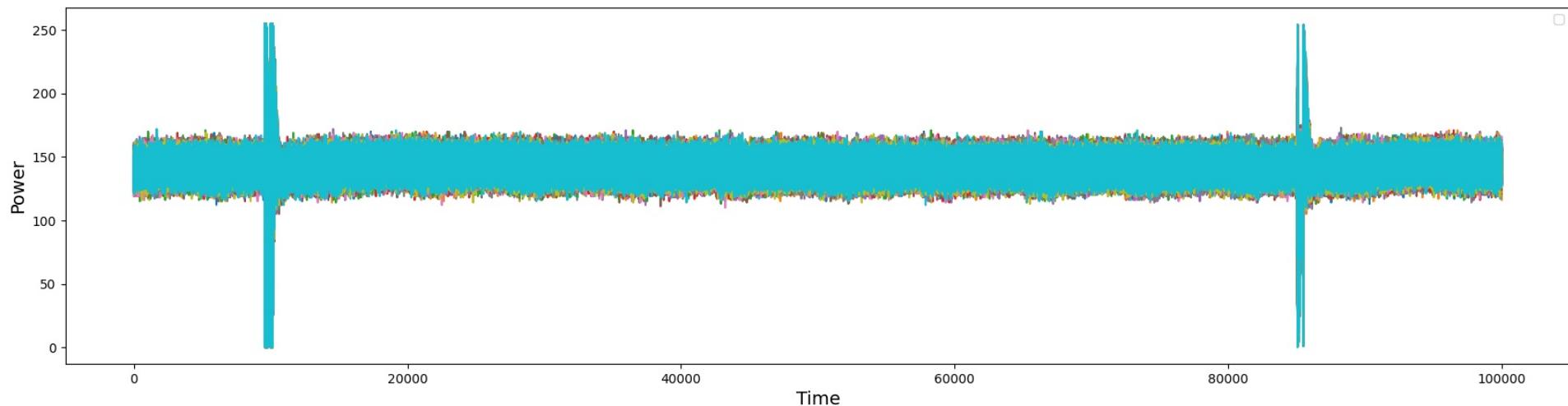
# Second test setup

- ESP32-C3 devkit @160MHz
  - Capacitors NOT removed
- Simple firmware
  - software AES (tinyAES)
  - GPIO as trigger
- Acquisition
  - LISN on both power rails (+3.3V/GND)
  - 1 Ohm resistor on VDD
- Rigol MSO5000 oscilloscope
  - 350MHz / 4GSPS



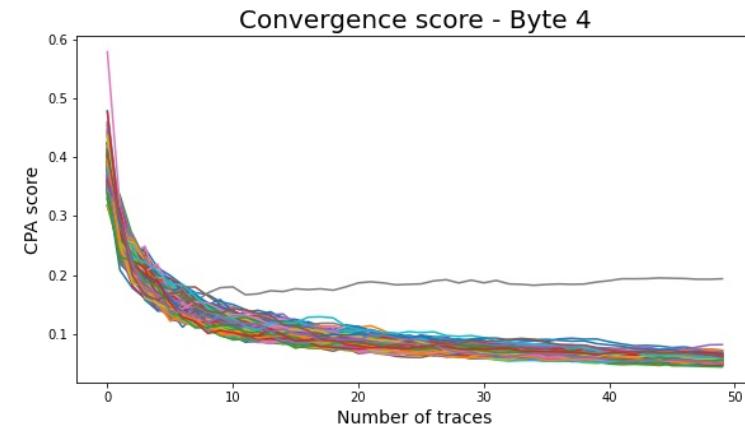
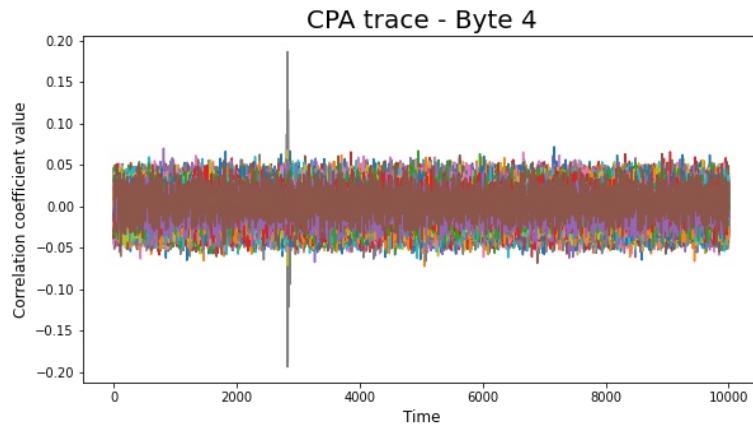
# Acquisition

- 50'000 averaged traces
- Random plaintext
- No resynchronization



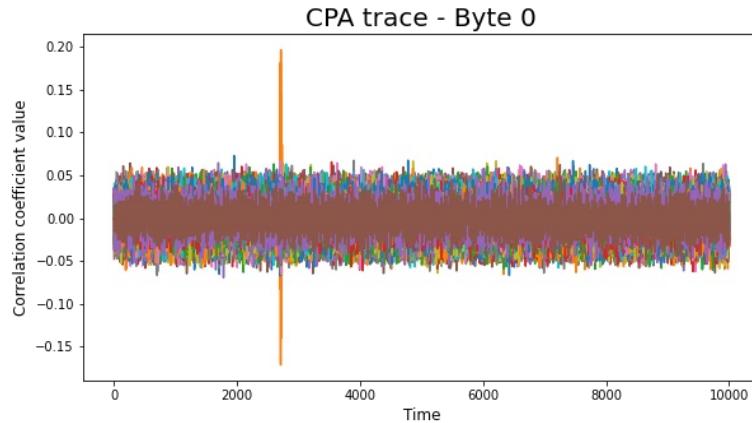
# Initial results

- Applying CPA on both trace sets reveals the key
- Not enough information to quantify each trace set quality

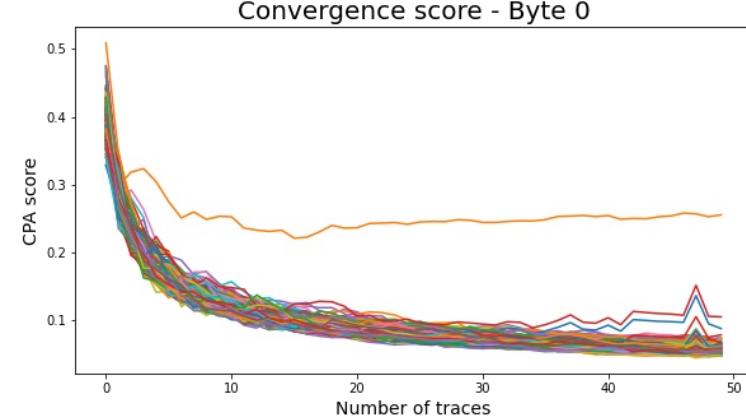
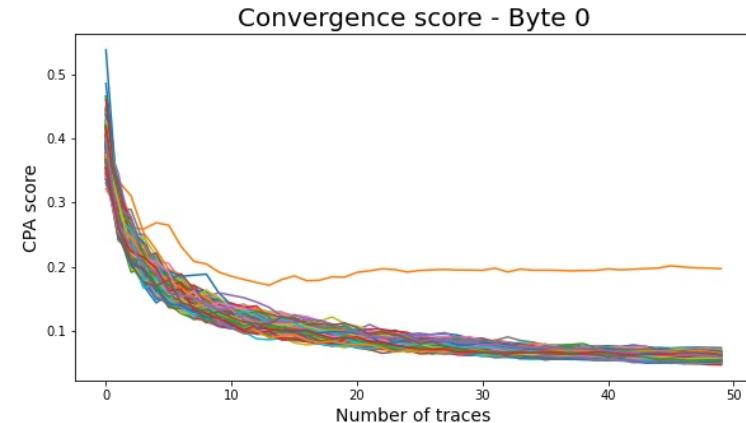
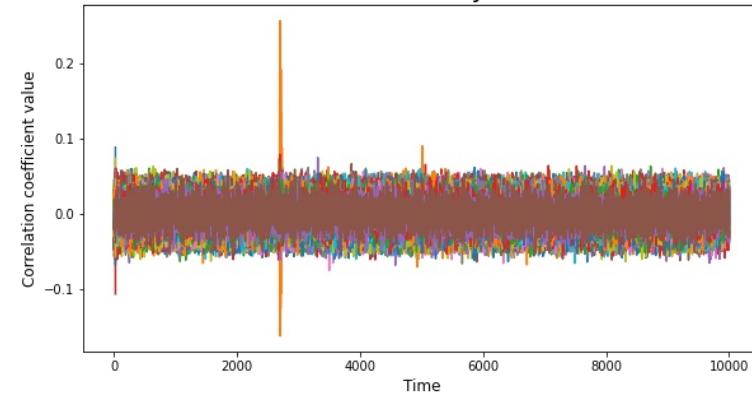


# LISN vs Shunt

LISN

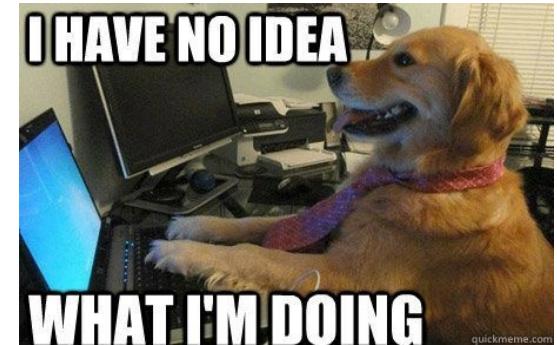


Shunt

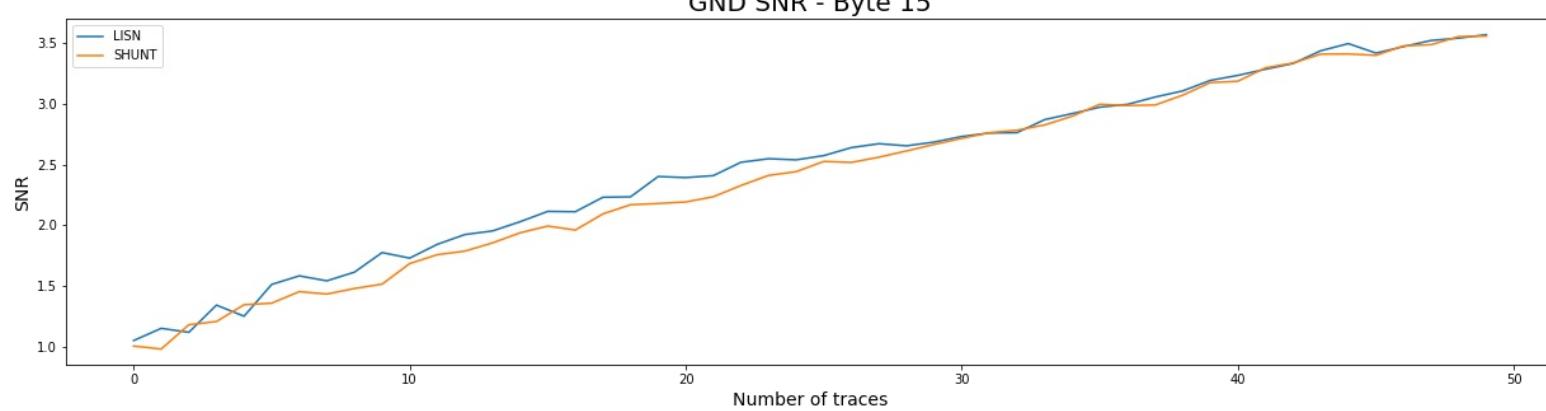
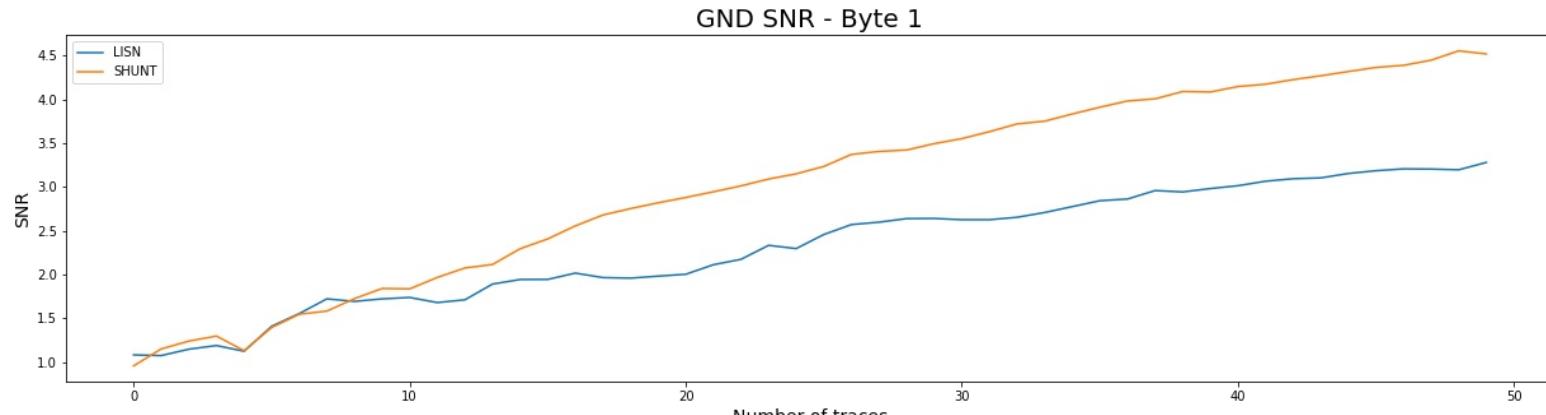


# Comparing CPA techniques

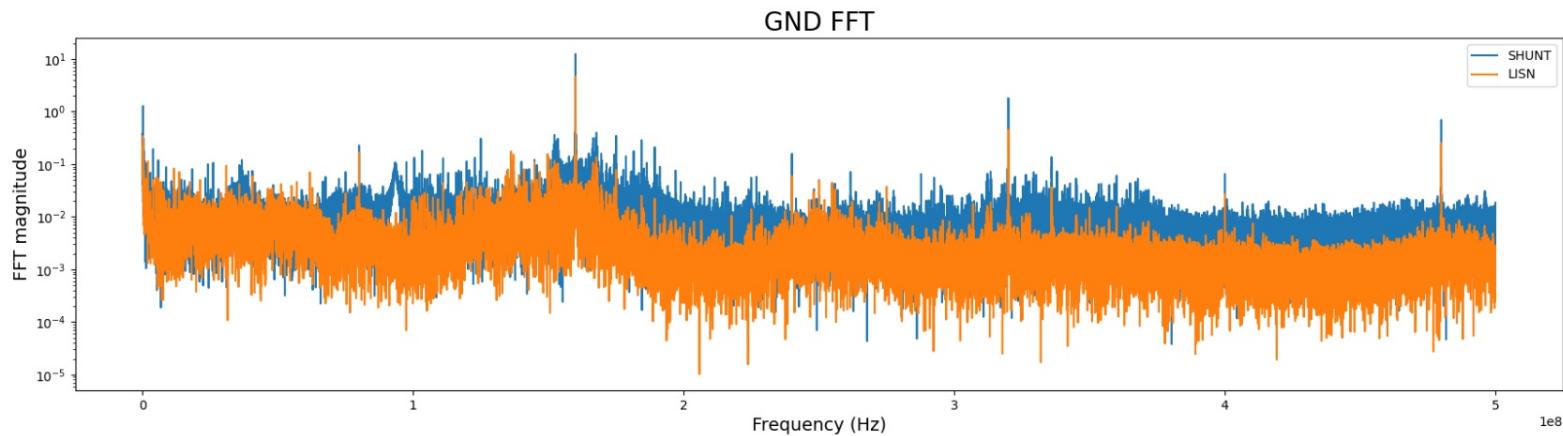
- No “official” way to compare sets of traces
- Ended up with some kind of “Signal over noise ratio”
- $\langle \text{correct guess correlation value} \rangle / \text{mean}(\langle \text{other correlation values} \rangle)$
- Gives a rough estimate of measurement quality



# “SNR” comparison



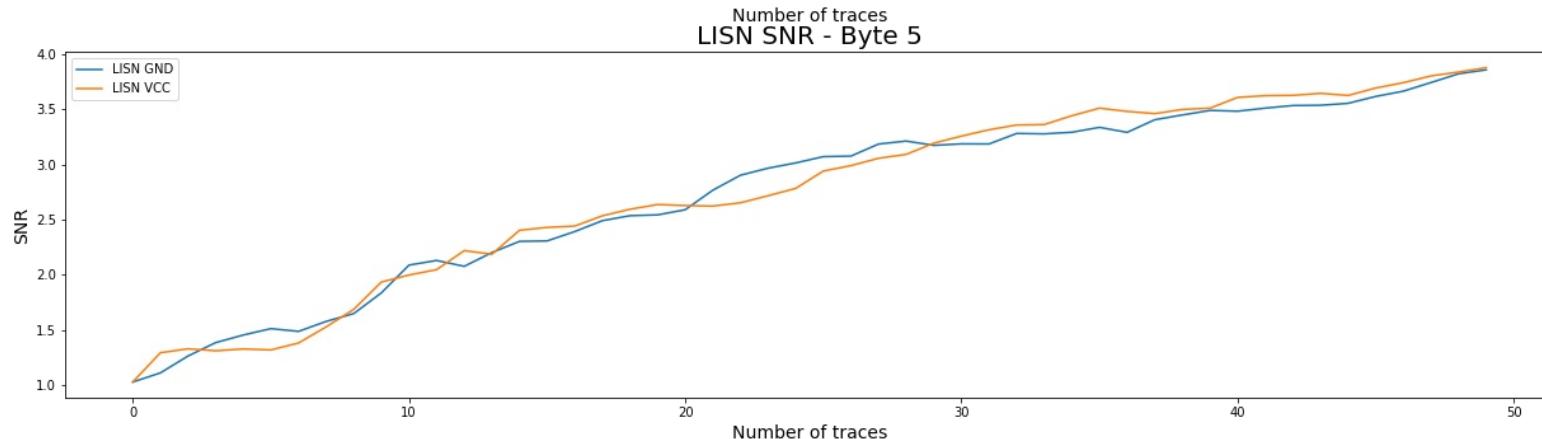
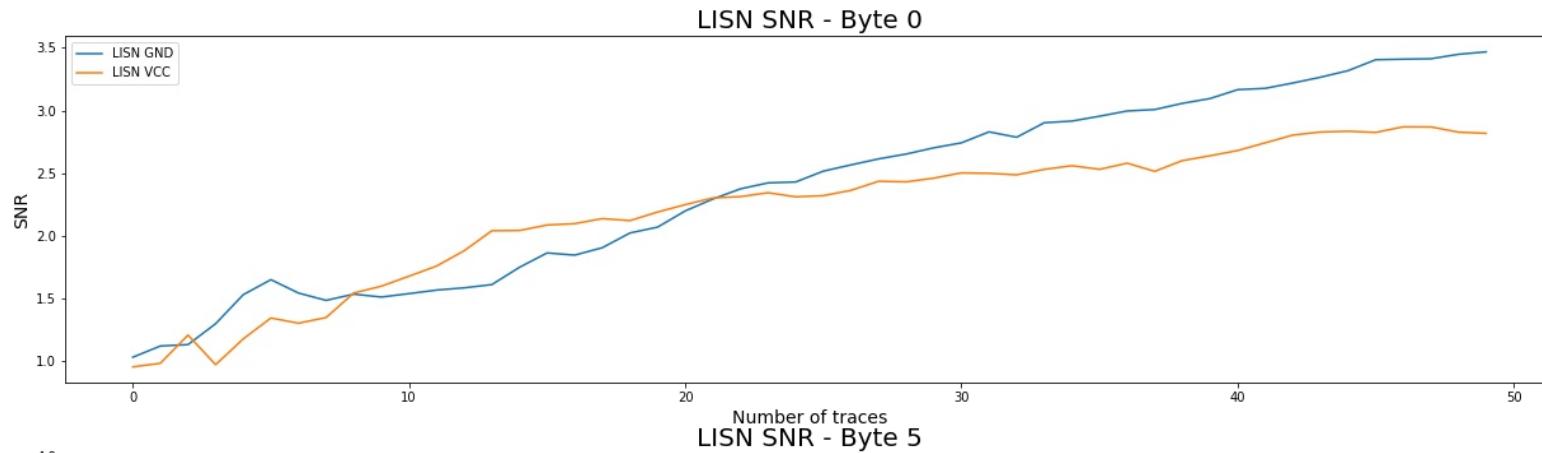
# FFT comparison



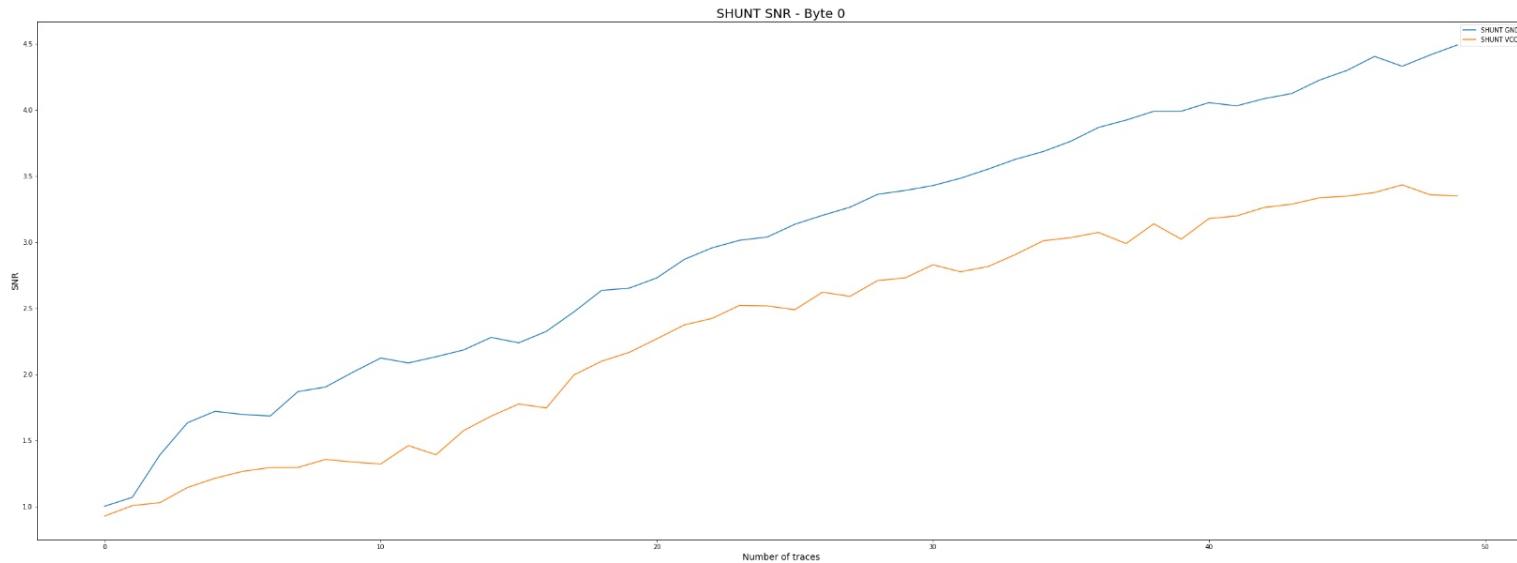
# VCC vs GND

- LISN provides measurement ports on both VCC and GND
- Did same acquisition on each measurement port
  - 50'000 averaged traces, random plaintext
- Measuring on GND provides slightly better results

# “SNR” LISN - VCC vs GND

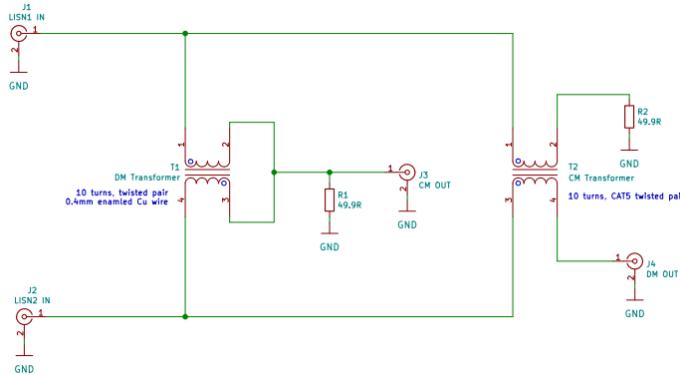


# VCC vs GND - Shunt



# Common mode / Differential mode

- Monitoring both VCC and GND allows to perform differential analysis
- Custom built CM/DM separator

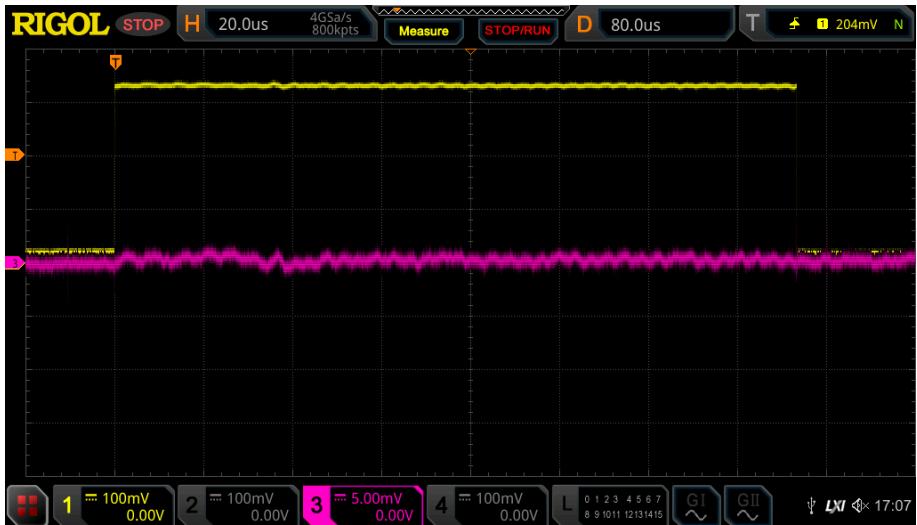


Differential (Normal) Mode Noise and Common Mode Noise explanation

<https://techweb.rohm.com/knowledge/emc/s-emc/01-s-emc/6899>

# CM / DM difference

- Tested on both setups
  - DM signal traces do provide some correlation
  - CM does not
- Might need more tests, as the separator only dampens the other signal



# Conclusions

- LISN provides a different way of acquiring side-channel information
- In practice, similar performance as a shunt resistor
  - Lower inline resistance. Could be useful for specific targets (non intrusive)
  - Signal is already AC-coupled
  - Measure is made on both lines
- EMC testing methodology allows to enhance signal quality by diminishing noise

# HydraSCA-LISN Limited Edition hardware.io NL 2022

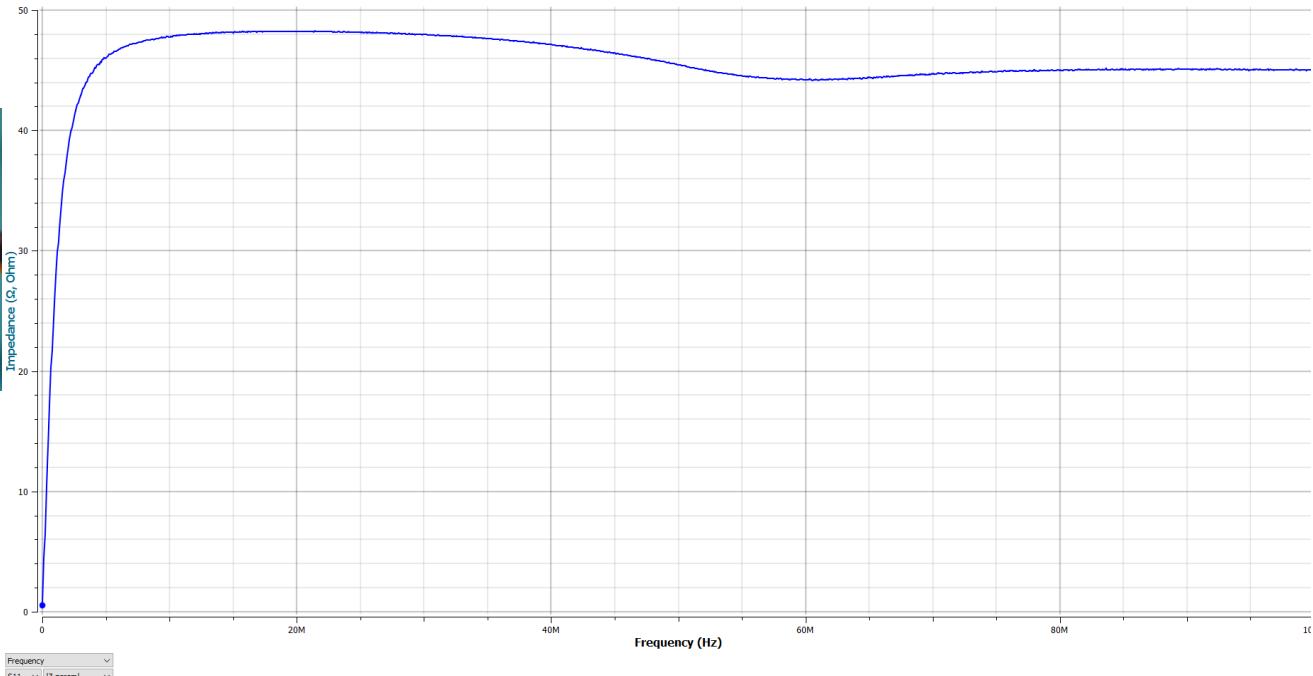
Exclusively for hardware.io NL 2022

We have 8 units available, find us after the talk !

## HydraSCA-LISN V1 R1

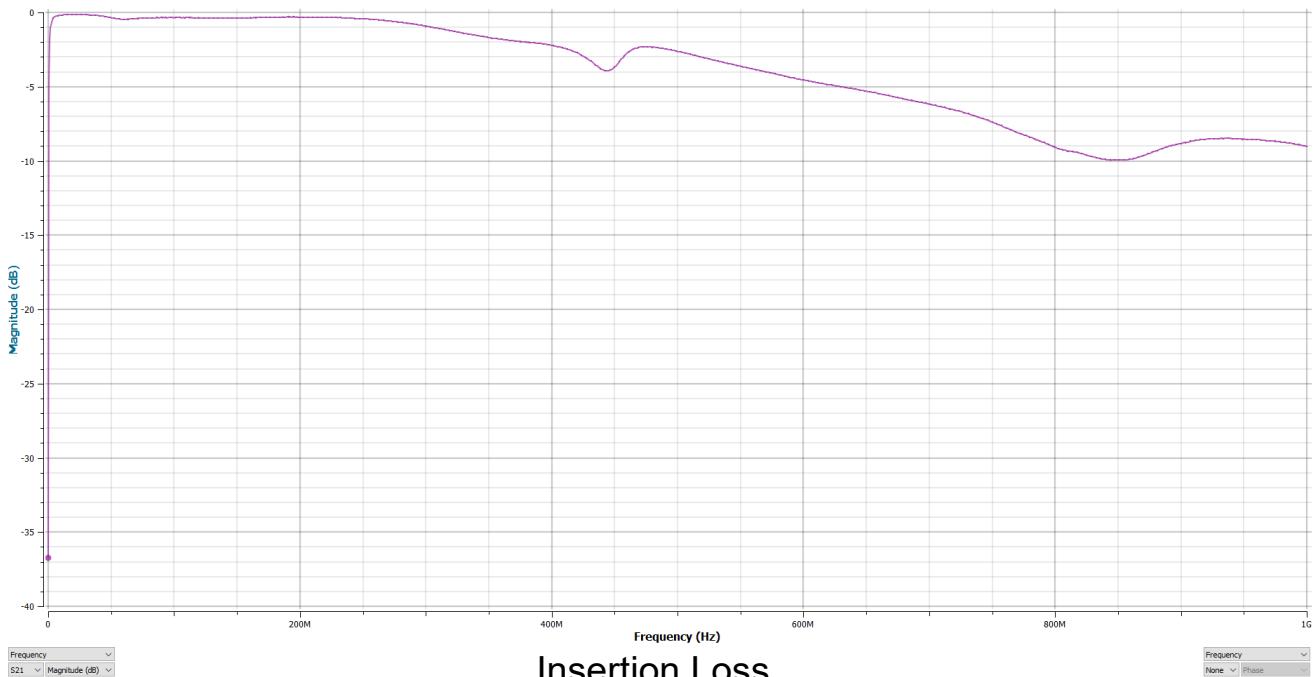


# BONUS



Impedance

# BONUS



# BONUS

